LFC10G1207

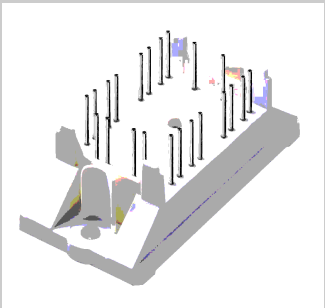
SISPM™

1200V 10A PIM(CIB) IGBT Module

Features

- Trench Field Stop Technology IGBT adopted
- Low Saturation Voltage
- Positive Temperature Coefficient
- Fast switching
- Free Wheeling Diodes with fast and soft reverse recovery
- Industrial Standard Package with insulated substrate
- Temperature Sensor included

Preliminary Data



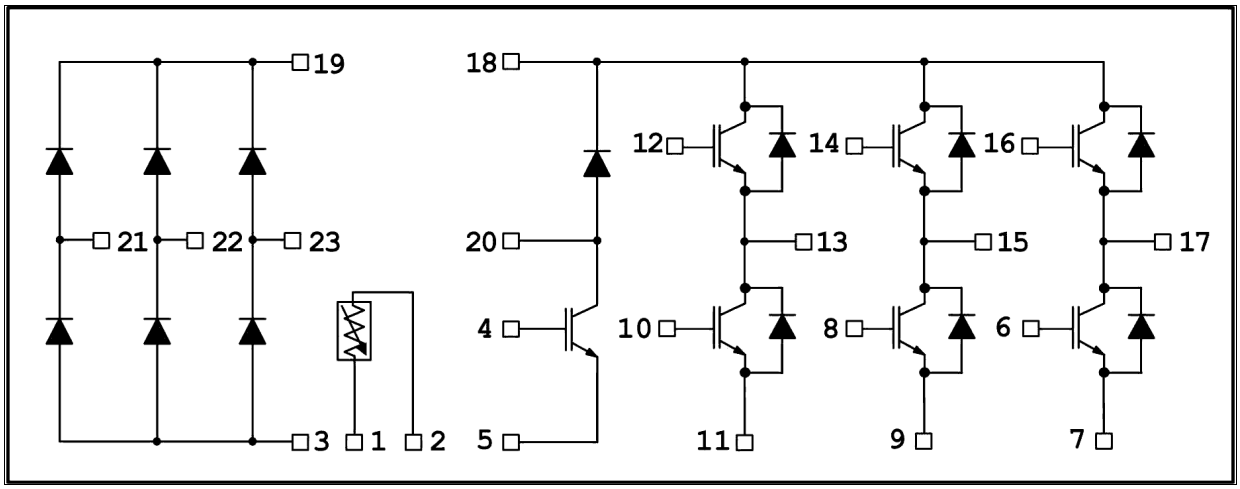
SISPM0

66.0 x 32.6 x 21.6mm

Applications

- Input from single or three phase grid
- Three Phase synchronous or asynchronous motor
- Dynamic Braking Operation

Internal Equivalent Circuit



Pin Description

Pin Number	Pin Name	Pin Description
1, 2	TH1, TH2	NTC-, NTC+
3	N	Negative DC Link Input
4	GB	Gate Input for Braking IGBT
5	EB	Emitter Input for Braking IGBT
6, 8, 10	GWN, GVN, GUN	Gate Input for Low-side W Phase, V Phase, U Phase
7, 9, 11	WN, VN, UN	Negative DC Link output W Phase, V Phase, U Phase
12, 14, 16	GUP, GVP, GWP	Gate Input for High-side U Phase, V Phase, W Phase
13, 15, 17	U, V, W	Output for U Phase, V Phase, W Phase
18	DCP	Positive DC Link Output
19	P	Positive DC Link Input
20	B	Output for Braking
21, 22, 23	R, S, T	Input for R Phase, S Phase, T Phase

Absolute Maximum Ratings T_C = 25 °C unless otherwise noted

Item	Symbol	Parameter	Conditions	Value	Units
Input Rectifier	V_{RPM}	Repetitive Peak Reverse Voltage		1600	V
	I_{FAV}	Forward Current per Diode	@ T_j = 150 °C, T_C = 80 °C	10	A
	I_{FSM}	Surge Forward Current (Chip level)	@ T_j = 150 °C, t_P = 10 ms, half sine wave	200	A
	I^2t	I^2t - Value (Chip level)	@ T_j = 150 °C, t_P = 10 ms, half sine wave	200	A^2s
	P_D	Maximum Power Dissipation	@ T_j = 150 °C, T_C = 80 °C	50	W
	T_j	Operating Junction Temperature *(1)	-	-40 ~ 125	°C
Transistor Inverter	V_{CES}	Collector-Emitter Breakdown Voltage	-	1200	V
	V_{GES}	Gate-Emitter Peak Voltage	-	± 20	V
	I_C	DC Collector Current	@ T_j = 175 °C, T_C = 80 °C	10	A
	I_{cpulse}	Repetitive Peak Collector Current	@ t_P = 1 ms	20	A
	P_D	Maximum Power Dissipation	@ T_j = 175 °C, T_C = 80 °C	60	W
	T_{SC}	SC Withstand Time (Chip level)	@ V_{GE} = 15 V, V_{CE} = 600 V	10	μs
	T_j	Operating Junction Temperature *(2)	-	-40 ~ 125	°C
Diode Inverter	V_{RRM}	Repetitive Peak Reverse Voltage	-	1200	V
	I_F	DC Forward Current	@ T_j = 150 °C,T_C = 80 °C	10	A
	I_{FRM}	Repetitive Peak Forward Current	@ t_P = 1 ms	20	A
	P_D	Maximum Power Dissipation	@ T_j = 150 °C, T_C = 80 °C	30	W
	T_j	Operating Junction Temperature *(1)	-	-40 ~ 125	°C
Transistor Brake	V_{CES}	Collector-Emitter Breakdown Voltage	-	1200	V
	V_{GES}	Gate-Emitter Peak Voltage	-	± 20	V
	I_C	DC Collector Current	@ T_j = 175 °C, T_C = 80 °C	8	A
	I_{cpulse}	Repetitive Peak Collector Current	@ t_P = 1 ms	16	A
	P_D	Maximum Power Dissipation	@ T_j = 175 °C, T_C = 80 °C	50	W
	T_{SC}	SC Withstand Time (Chip level)	@ V_{GE} = 15 V, V_{CE} = 600 V	10	μs
	T_j	Operating Junction Temperature *(2)	-	-40 ~ 125	°C
Diode Brake	V_{RRM}	Repetitive Peak Reverse Voltage	-	1200	V
	I_F	DC Forward Current	@ T_j = 150 °C, T_C = 80 °C	8	A
	I_{FRM}	Repetitive Peak Forward Current	@ t_P = 1 ms	16	A
	P_D	Maximum Power Dissipation	@ T_j = 150 °C, T_C = 80 °C	30	W
	T_j	Operating Junction Temperature *(1)	-	-40 ~ 125	°C
Module	T_{stg}	Storage Temperature	-	-40 ~ 125	°C
	V_{iso}	Isolation Voltage	@ AC 1minute	2500	V
	W	Weight	-	30	g

(Note *1) The Maximum junction temperature of chip is 150 °C.
(Note *2) The Maximum junction temperature of chip is 175 °C.

Electrical Characteristics T_C = 25 °C unless otherwise noted

Input Rectifier Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
V_F	Diode Forward Voltage	T_C = 25 °C, I_F = 10 A	-	0.9	-	V
		T_C = 125 °C, I_F = 10 A	-	1.0	-	V
V_{to}	Threshold Voltage (Chip level)	T_C = 125 °C	-	0.83	-	V
I_R	Reverse Current (Chip level)	T_C = 25 °C, V_{RRM} = 600 V	-	0.05	-	mA
r_t	Slope Resistance (Chip level)	T_C = 125 °C	-	20.8	-	mΩ
$R_{th(J-C)}$	Thermal Resistance (DIODE Part)	Junction-to-Case	-	1.4	-	°C/W

Transistor-Inverter Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$V_{GE(th)}$	Gate-Emitter threshold Voltage	V_{CE} = V_{GE}, I_{CE} = 10 mA	-	6.4	-	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	T_C = 25 °C, I_{CE} = 10 A, V_{GE} = 15 V	-	2.1	-	V
		T_C = 125 °C, I_{CE} = 10 A, V_{GE} = 15 V	-	2.5	-	V
I_{CES}	Collector-Emitter Cut-off Current	V_{GE} = 0 V, V_{CE} = 1200 V	-	-	1	mA
I_{GES}	Gate-Emitter Leakage Current	V_{GE} = 20 V, V_{CE} = 0 V	-	-	120	nA
C_{iss}	Input Capacitance	V_{CE} = 25 V, V_{GE} = 0 V f = 1 MHz, T_C = 25 °C (Chip level)	-	625	-	pF
C_{oss}	Output Capacitance		-	60	-	pF
C_{rss}	Reverse Transfer Capacitance		-	40	-	pF
t_d(on)	Turn-On Delay Time	T_C = 125 °C, $R_{G\ ON}$ = 32 Ω $R_{G\ OFF}$ = 32 Ω, L = 500 μH V_{CE} = 600 V, V_{GE} = -15 V~15 V I_{CE} = 10 A	-	10	-	ns
t_r	Rise Time		-	28	-	ns
t_d(off)	Turn-Off Delay Time		-	270	-	ns
t_f	Fall Time		-	172	-	ns
E_{on}	Turn-On Switching Loss		-	1.1	-	mJ
E_{off}	Turn-Off Switching Loss		-	0.9	-	mJ
E_{ts}	Total Switching Loss		-	2.0	-	mJ
Q_G	Total Gate Charge	V_{GE} = 0 V ~ 15 V	-	66	-	nC
Q_{GE}	Gate-Emitter Charge		-	19	-	nC
Q_{GC}	Gate-Collector Charge		-	28	-	nC
$R_{th(J-C)}$	Thermal Resistance (IGBT Part)	Junction-to-Case		1.4	-	°C/W

Diode-Inverter Characteristics T_C = 25 °C unless otherwise noted

Symbol	Parameter	Conditions		Min	Typ	Max	Units
V_F	Diode Forward Voltage	I_F = 10 A, V_{GE} = 0 V	T_C = 125 °C	-	1.9	-	V
t_{rr}	Diode Reverse Recovery Time	$R_{G\ ON}$ = 32 Ω L = 500 μH V_{CE} = 1200 V V_{GE} = -15 V~15 V I_{CE} = 10 A	T_C = 125 °C	-	393	-	ns
I_{RRM}	Diode Peak Reverse Recovery Current		T_C = 125 °C	-	16	-	A
Q_{rr}	Diode Reverse Recovery Charge		T_C = 125 °C	-	2.2	-	μC
E_{rr}	Diode Reverse Recovery Energy		T_C = 125 °C	-	0.9	-	mJ
$R_{th(J-C)}$	Thermal Resistance (DIODE Part)	Junction-to-Case		-	2.2	-	°C/W

Transistor- Brake Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$V_{GE(th)}$	Gate-Emitter threshold Voltage	V_{CE} = V_{GE}, I_{CE} = 10 mA	-	6.3	-	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	T_C = 25 °C, I_{CE} = 8 A, V_{GE} = 15 V	-	2.0	-	V
		T_C = 125 °C, I_{CE} = 8 A, V_{GE} = 15 V	-	2.4	-	V
I_{CES}	Collector-Emitter Cut-off Current	V_{GE} = 0 V, V_{CE} = 1200 V	-	-	1	mA
I_{GES}	Gate-Emitter Leakage Current	V_{GE} = 20 V, V_{CE} = 0 V	-	-	120	nA
C_{iss}	Input Capacitance	V_{CE} = 25 V, V_{GE} = 0 V f = 1 MHz, T_C = 25 °C (Chip level)	-	490	-	pF
C_{oss}	Output Capacitance		-	50	-	pF
C_{rss}	Reverse Transfer Capacitance		-	30	-	pF

Symbol	Parameter	Conditions	Min	Typ	Max	Units
t_d(on)	Turn-On Delay Time	T_C = 125 °C, $R_{G\ ON}$ = 32 Ω $R_{G\ OFF}$ = 32 Ω, L = 500 μH V_{CE} = 600 V, V_{GE} = -15 V~15 V I_{CE} = 8 A	-	4.9	-	ns
t_r	Rise Time		-	24	-	ns
t_d(off)	Turn-Off Delay Time		-	269	-	ns
t_f	Fall Time		-	210	-	ns
E_{on}	Turn-On Switching Loss		-	1.0	-	mJ
E_{off}	Turn-Off Switching Loss		-	0.9	-	mJ
E_{ts}	Total Switching Loss		-	1.9	-	mJ
Q_G	Total Gate Charge	V_{GE} = 0 V ~ 15 V	-	56	-	nC
Q_{GE}	Gate-Emitter Charge		-	19	-	nC
Q_{GC}	Gate-Collector Charge		-	23	-	nC
$R_{th(J-C)}$	Thermal Resistance (IGBT Part)	Junction-to-Case		1.8	-	°C/W

Diode-Brake Characteristics T_C = 25 °C unless otherwise noted0

Symbol	Parameter	Test Conditions		Min	Typ	Max	Units
V_F	Diode Forward Voltage	I_F = 8 A, V_{GE} = 0 V	T_C = 125 °C	-	1.7	-	V
t_{rr}	Diode Reverse Recovery Time	$R_{G\ ON}$ = 32 Ω L = 500 μH V_{CE} = 600 V V_{GE} = -15 V ~15 V I_{CE} = 8 A	T_C = 125 °C	-	607	-	ns
I_{RRM}	Diode Peak Reverse Recovery Current		T_C = 125 °C	-	8	-	A
Q_{rr}	Diode Reverse Recovery Charge		T_C = 125 °C	-	1.8	-	μC
E_{rr}	Diode Reverse Recovery Energy		T_C = 125 °C	-	0.7	-	mJ
$R_{th(J-C)}$	Thermal Resistance (DIODE Part)	Junction-to-Case		-	2.0	-	°C/W

NTC thermistar Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
R_{25}	Resistance	T_C = 25 °C	-	22	-	kΩ
P	Power	T_C = 25 °C	-	210	-	mW
$B_{25/100}$	B Constant	T_C = 25 °C, ± 3% tolerance	-	4000	-	K

* This specifications may not be considered as an assurance of characteristics and may not have same characteristics.
in case of using different test systems from @LSIS. We therefore strongly recommend prior consultation of our engineers.

Input Rectifier

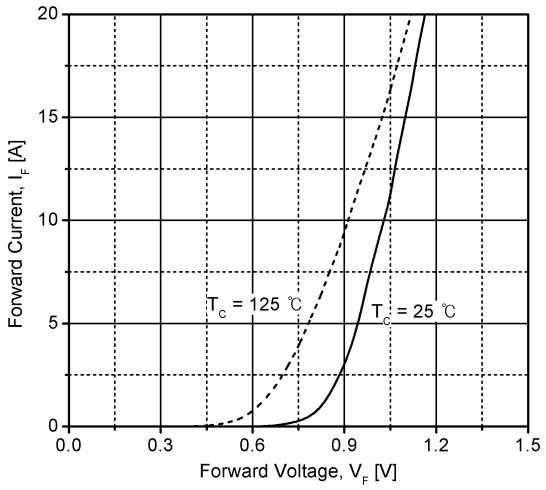


Fig 1. Typical Diode Forward Characteristics

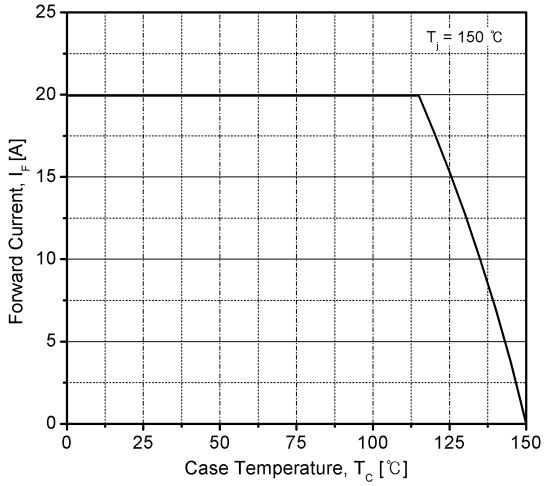


Fig 2. Case Temperature vs. Forward Current

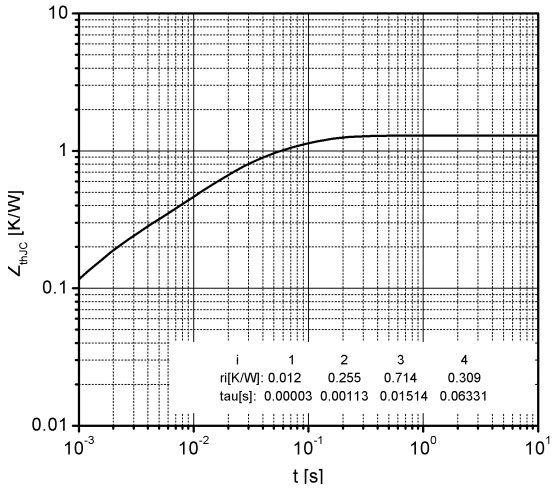


Fig 3. Typical Diode Thermal Impedance

Transistor-Inverter/Diode-Inverter

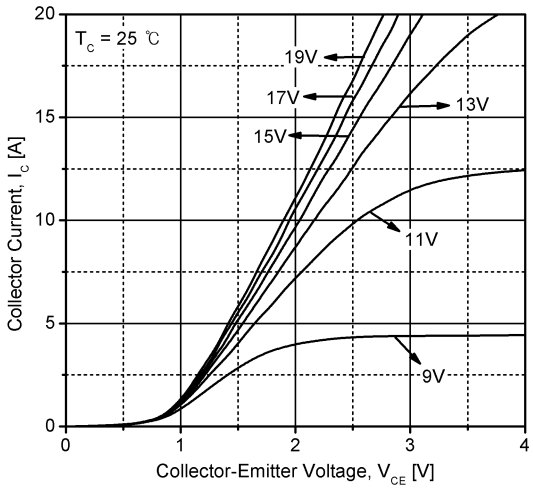


Fig 4. Typical IGBT Output Characteristics

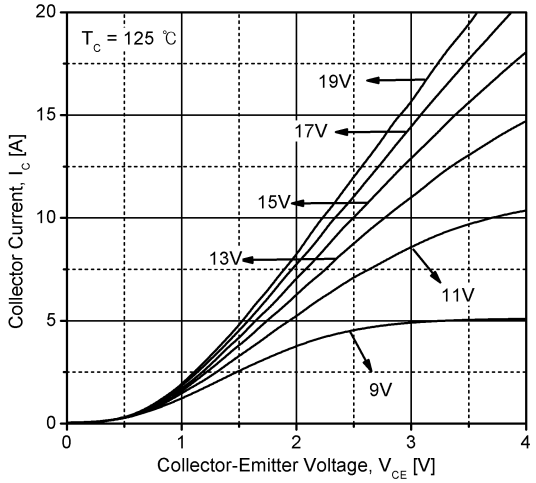


Fig 5. Typical IGBT Output Characteristics

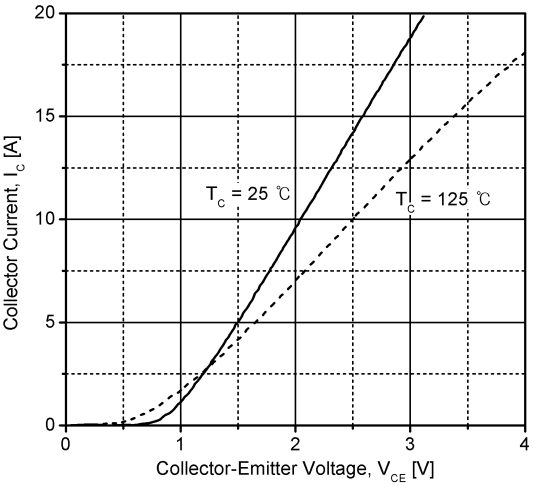


Fig 6. Typical IGBT Output Characteristics

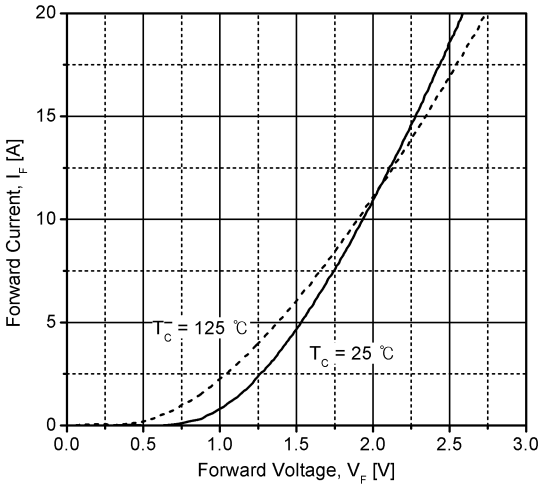


Fig 7. Typical Diode Forward Characteristics

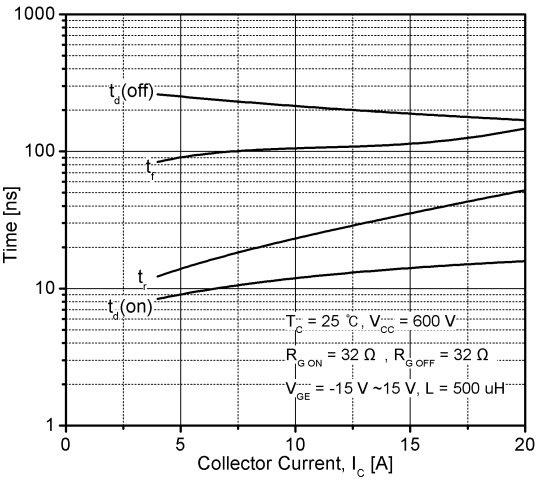


Fig 8. Typical Switching Time vs. Collector Current

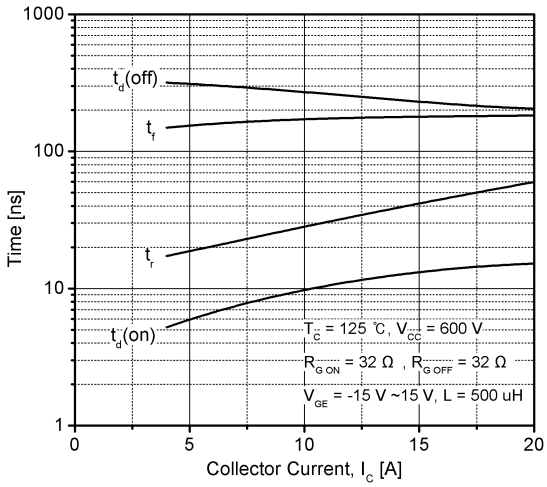


Fig 9. Typical Switching Time vs. Collector Current

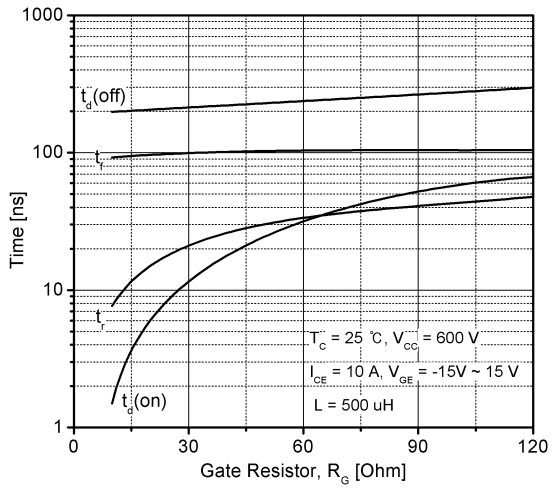


Fig 10. Typical Switching Time vs. Gate Resistor

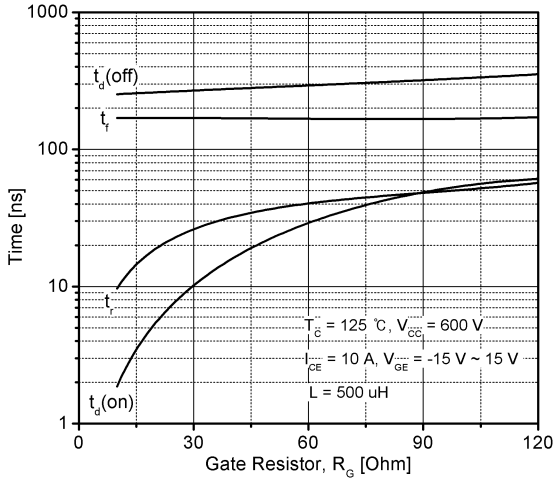


Fig 11. Typical Switching Time vs. Gate Resistor

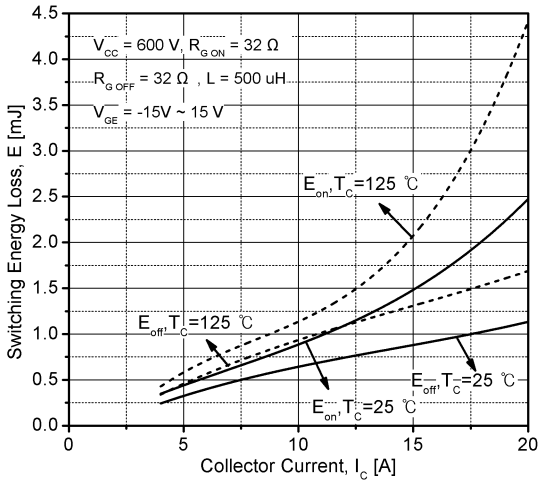


Fig 12. Typical IGBT Switching Loss

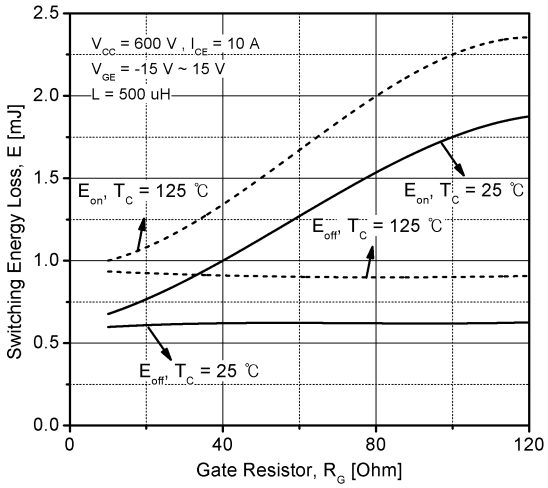


Fig 13. Typical IGBT Switching Loss

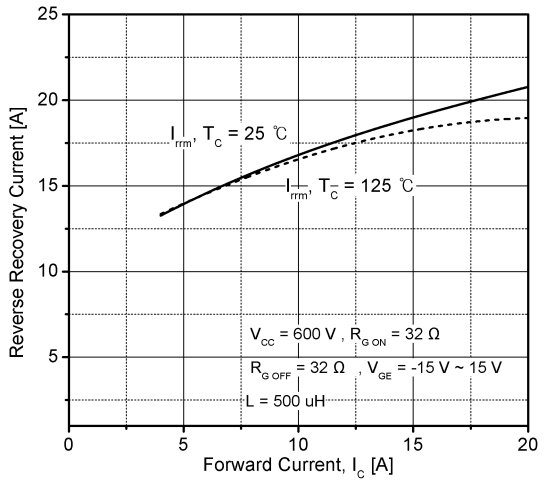


Fig 14. Typical Recovery Characteristics of Diode

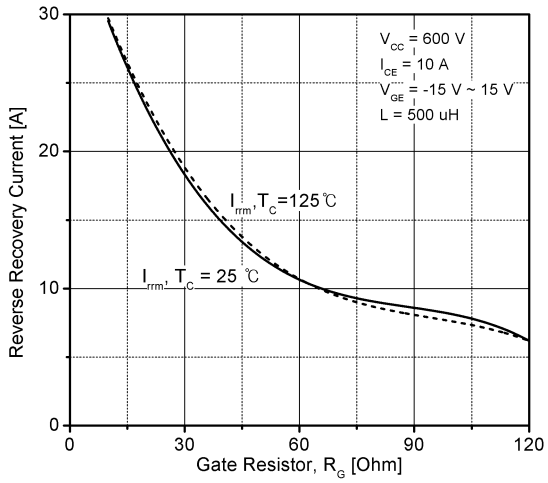


Fig 15. Typical Recovery Characteristics of Diode

Transistor-Inverter/Diode-Inverter

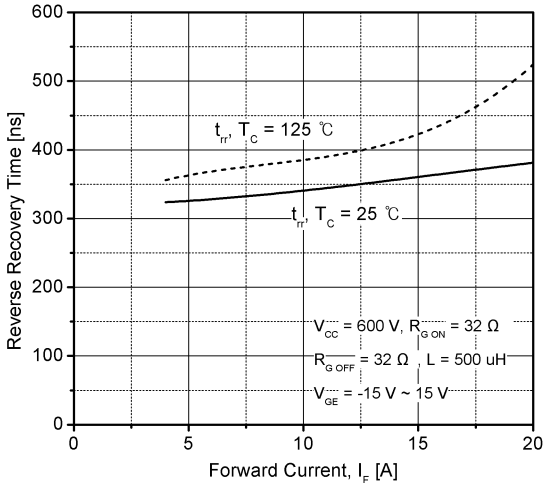


Fig 16. Typical Recovery Characteristics of Diode

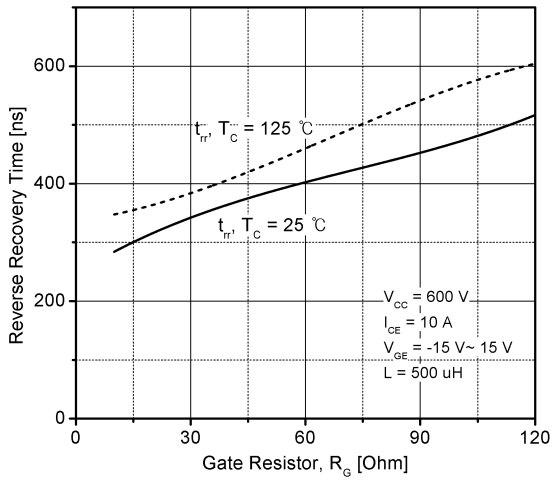


Fig 17. Typical Recovery Characteristics of Diode

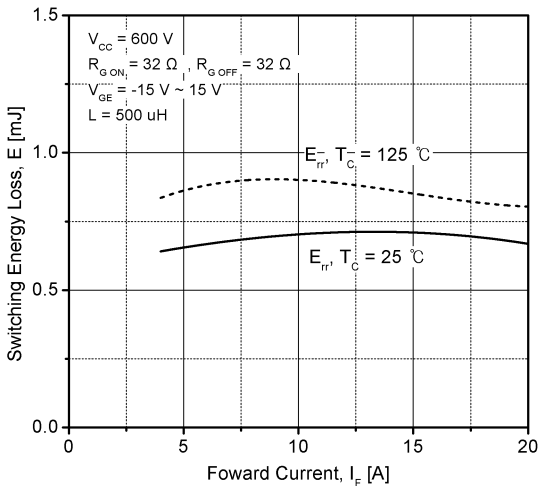


Fig 18. Typical Diode Switching Loss

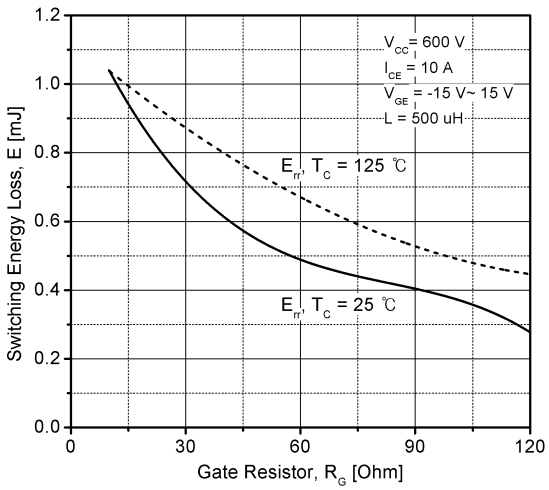


Fig 19. Typical Diode Switching Loss

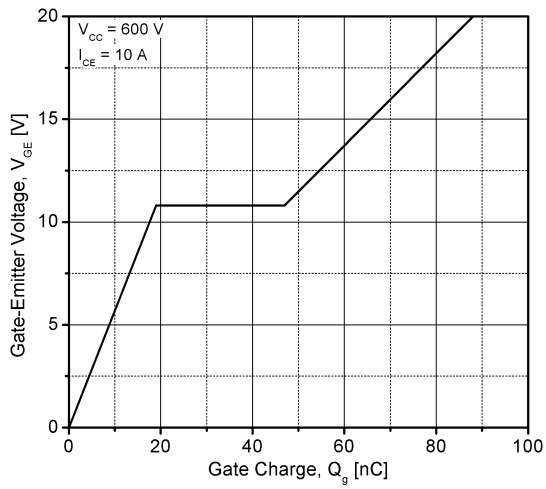


Fig 20. Typical Gate Charge Characteristics

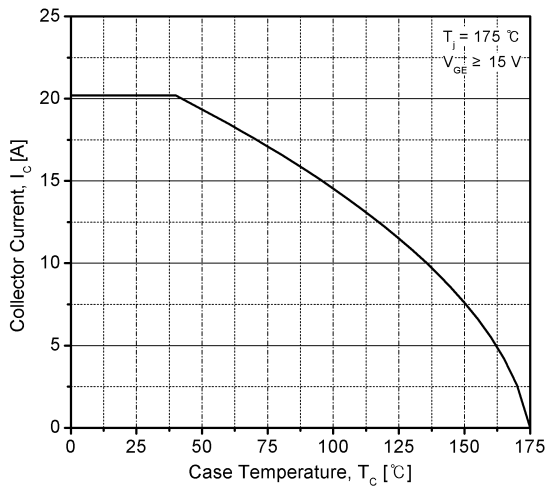


Fig 21. Case Temperature vs. Collector Current

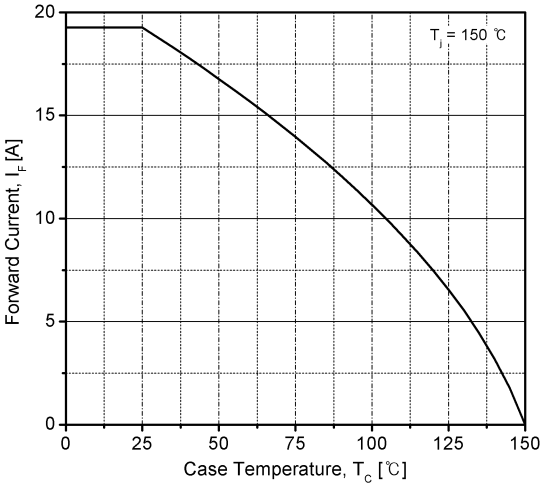


Fig 22. Case Temperature vs. Forward Current

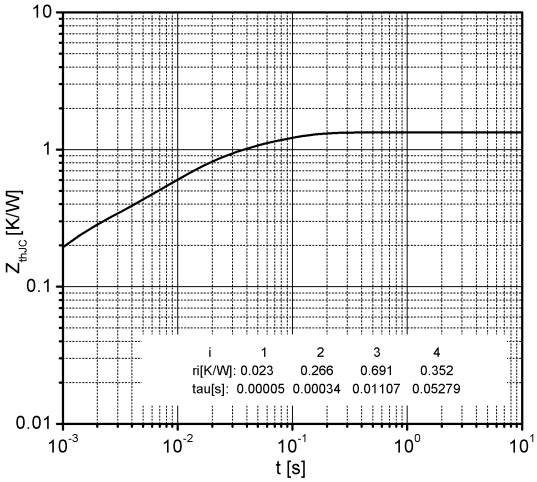


Fig 23. Typical Igbt Thermal Impedance

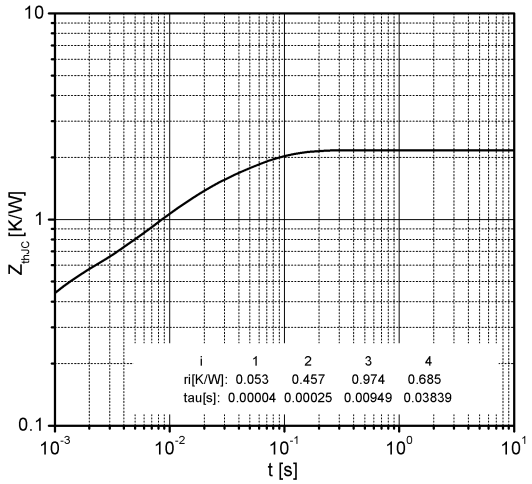


Fig 24. Typical Diode Thermal Impedance

Transistor-Brake/Diode-Brake

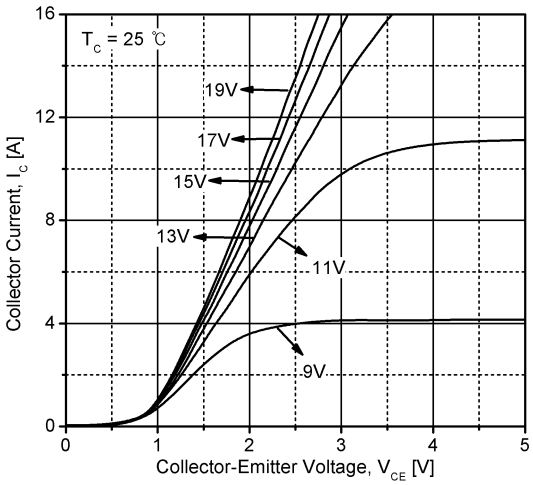


Fig 25. Typical IGBT Output Characteristics

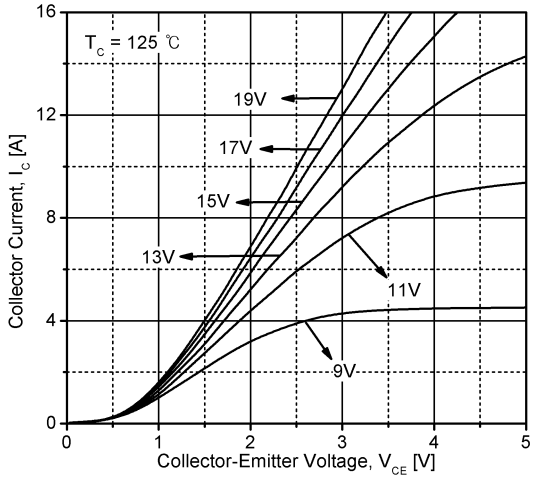


Fig 26. Typical IGBT Output Characteristics

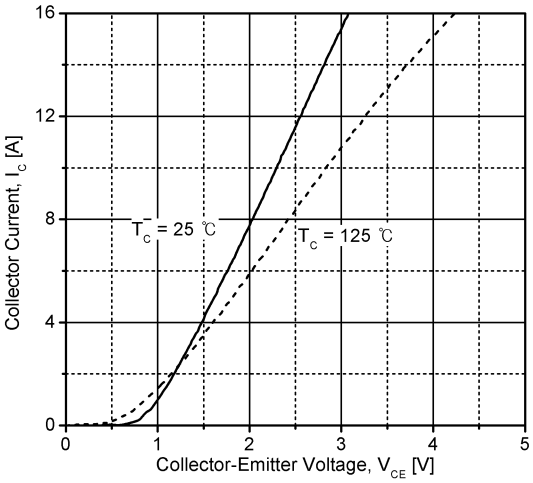


Fig 27. Typical IGBT Output Characteristics

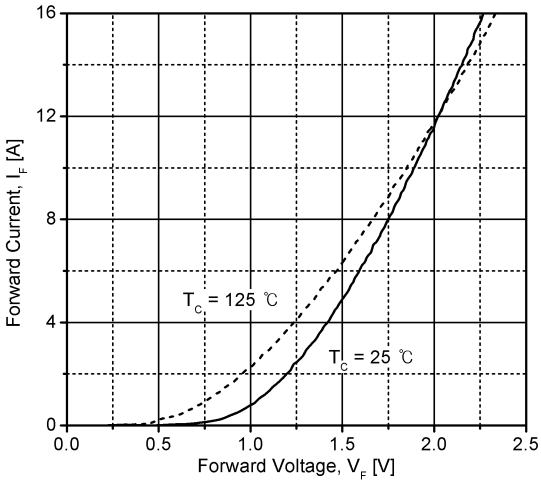


Fig 28. Typical Diode Forward Characteristics

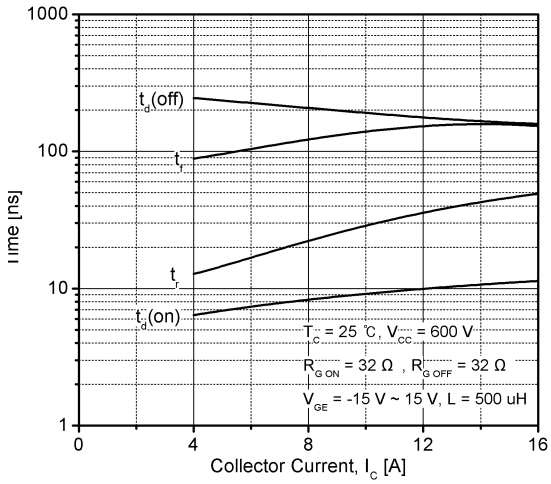


Fig 29. Typical Switching Time vs. Collector Current

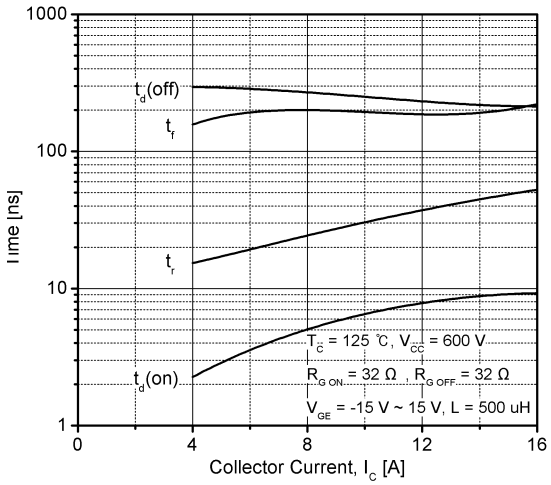


Fig 30. Typical Switching Time vs. Collector Current

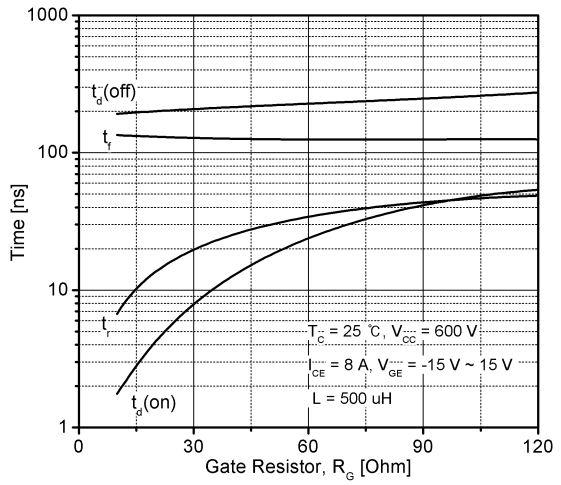


Fig 31. Typical Switching Time vs. Gate Resistor

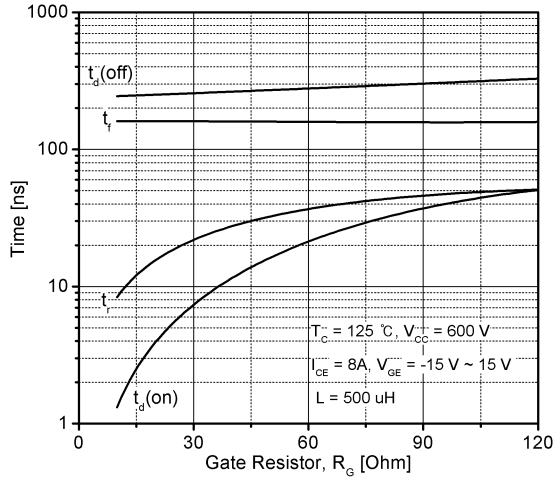


Fig 32. Typical Switching Time vs. Gate Resistor

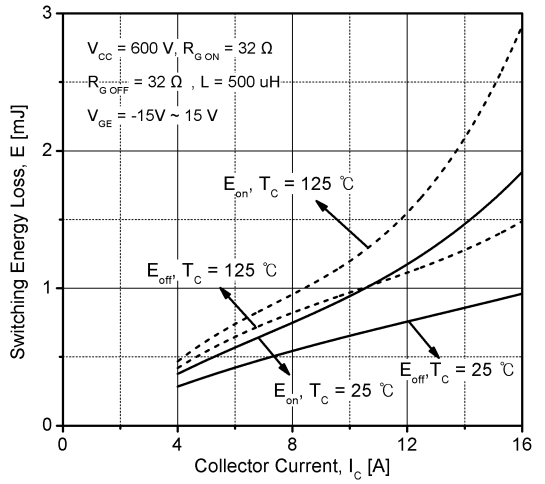


Fig 33. Typical IGBT Switching Loss

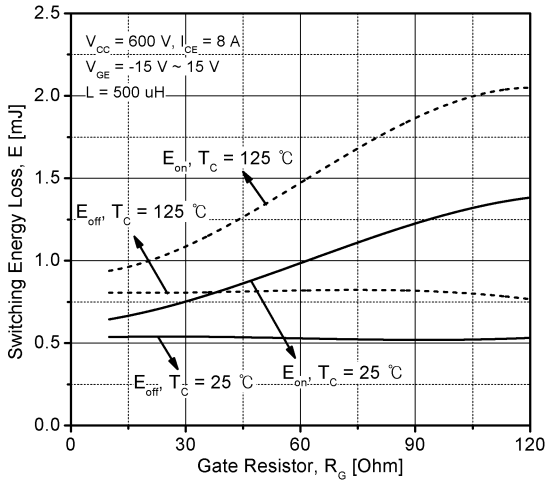


Fig 34. Typical IGBT Switching Loss

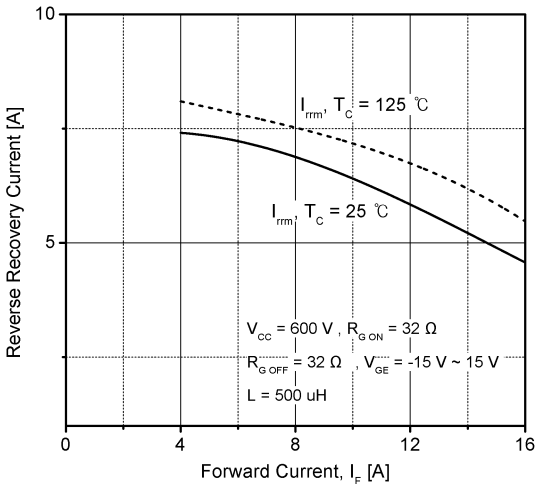


Fig 35. Typical Recovery Characteristics of Diode

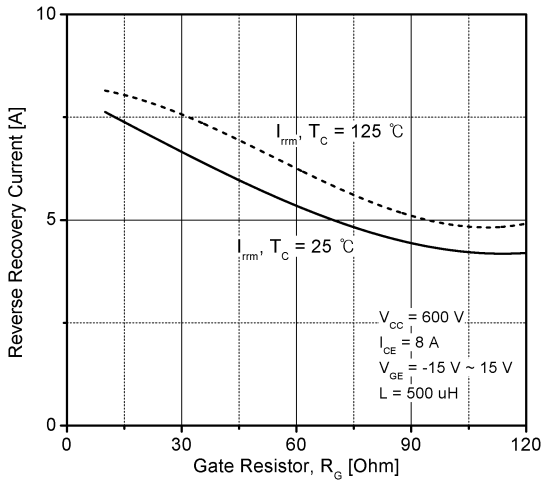


Fig 36. Typical Recovery Characteristics of Diode

Transistor-Brake/Diode-Brake

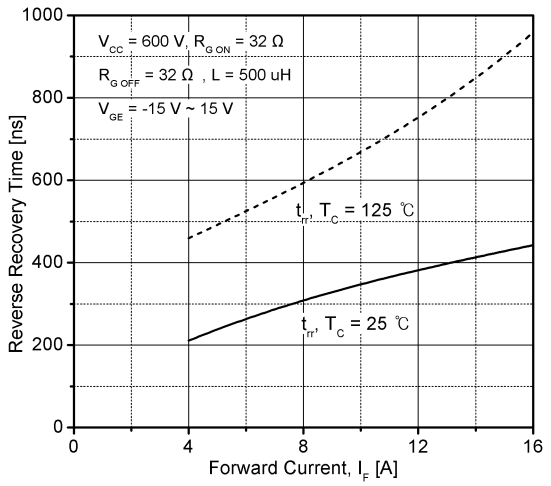


Fig 37. Typical Recovery Characteristics of Diode

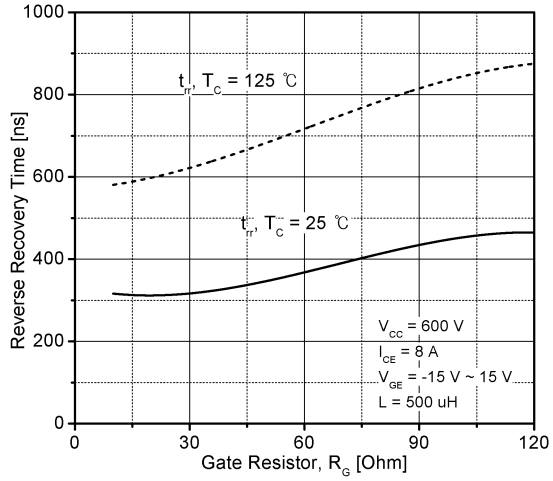


Fig 38. Typical Recovery Characteristics of Diode

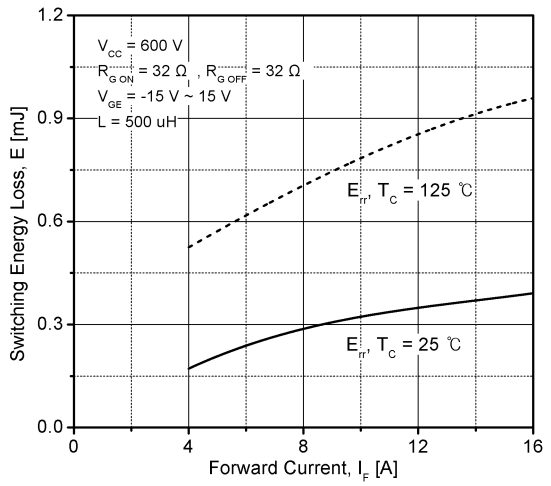


Fig 39. Typical Diode Switching Loss

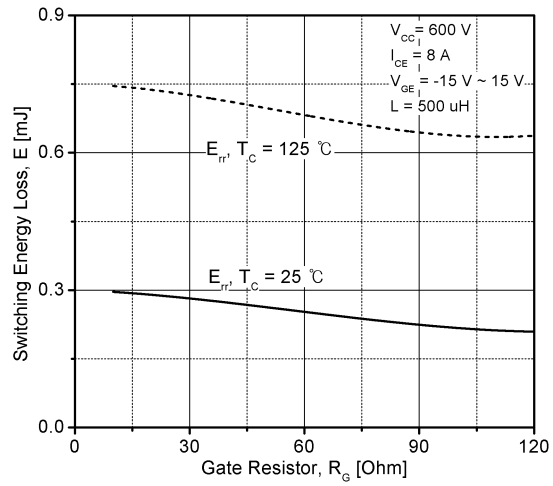


Fig 40. Typical Diode Switching Loss

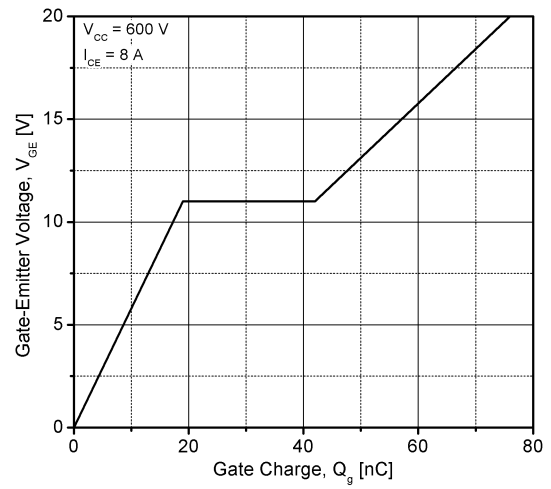


Fig 41. Typical Gate Charge Characteristics

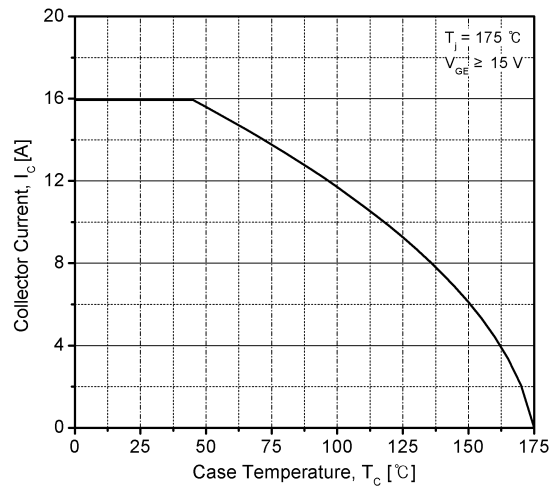


Fig 42. Case Temperature vs. Collector Current

Transistor-Brake/Diode-Brake

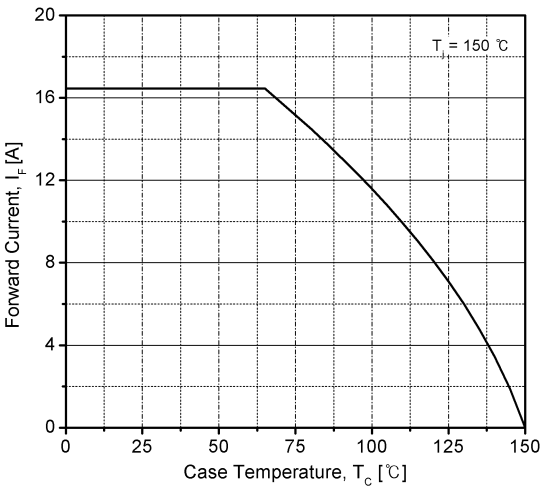


Fig 43. Case Temperature vs. Forward Current

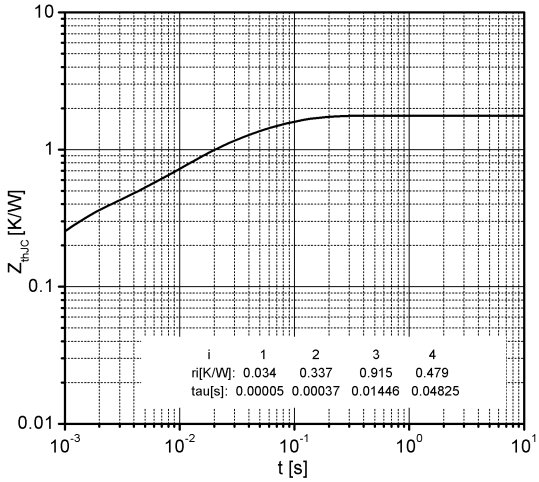


Fig 44. Typical Igbt Thermal Impedance

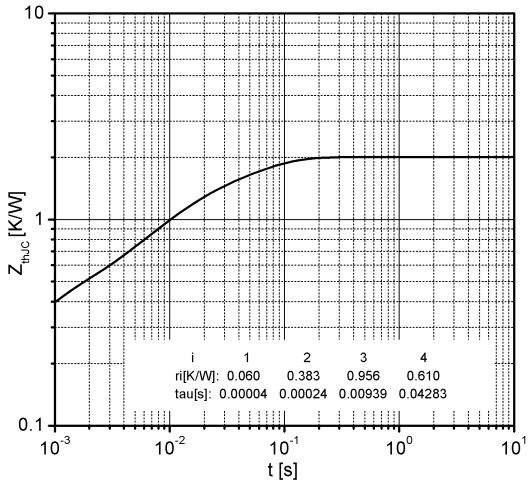


Fig 45. Typical Diode Thermal Impedance

NTC

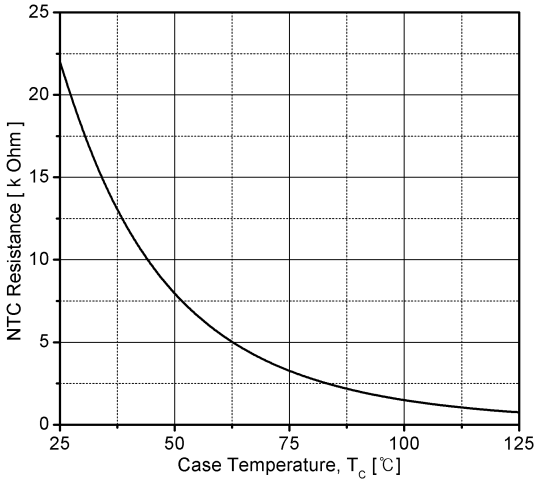


Fig 46. Typical NTC Characteristics

Package Dimension(Dimension in mm)